



# IECEX Quality Assessment Report Summary

## INTERNATIONAL ELECTROTECHNICAL COMMISSION IEC Certification Scheme for Explosive Atmospheres

for rules and details of the IECEx Scheme visit [www.iecex.com](http://www.iecex.com)

<b>QAR Reference No.</b>	DE/TUR/QAR11.0001/03	<b>Status</b>	Current
<b>QAR Free Ref. No.</b>	124791153	<b>Date of Issue</b>	2018-10-18
<b>Detail of change</b>	Re-Certification	<b>Valid until</b>	2021-10-25
<b>Site(s) audited</b>	Kaiser Optical Systems, Inc., 371 Parkland Plaza, Ann Arbor, MI, 48103	<b>Audit date</b>	2018-09-25
<b>Issuing ExCB</b>	TUR - TUV Rheinland Industrie Service GmbH		
<b>Manufacturer</b>	Kaiser Optical Systems, Inc., 371 Parkland Plaza, Ann Arbor, MI, 48103		
<b>Location of Manufacturer</b>	United States of America		
<b>Product information</b>	Analyser Base Units and Raman WetHead and AirHead Probes, Optical Systems, Optograph Analyzer Base Units, Raman WetHead, AirHead and, PhAT Probes		
<b>Protection concept</b>	Flameproof enclosure - Ex d;; Pressurized enclosures "p";; Intrinsic safety "i";; Optical radiation "op is"		
<b>Related QARs</b>			
DE/TUR/QAR11.0001/00	DE/TUR/QAR11.0001/01	DE/TUR/QAR11.0001/02	DE/TUR/QAR11.0001/03
<b>Related Certificates (manual insertion)</b>	N/A		
<b>Related Certificates (automatic linking)</b>	N/A		
<b>Related Certificates for previous versions</b>			
IECEX ITS 14.0014X issue: 0	IECEX ITS 14.0014X issue: 1	IECEX ITS 14.0015X issue: 0	IECEX ITS 14.0015X issue: 1
<b>Comments</b>	N/A		